

Target thickness $\leftrightarrow A_N$

polarim. mtg.
14.10.15

Processes:

- dE/dx energy loss in target \rightarrow shift in A_N
- multiple scattering in target \rightarrow broadened hit distributions

Implementation:

- Longitudinally segmented detectors
- Toy MC
- Fits to hit distributions
- Fudge factor

Results:

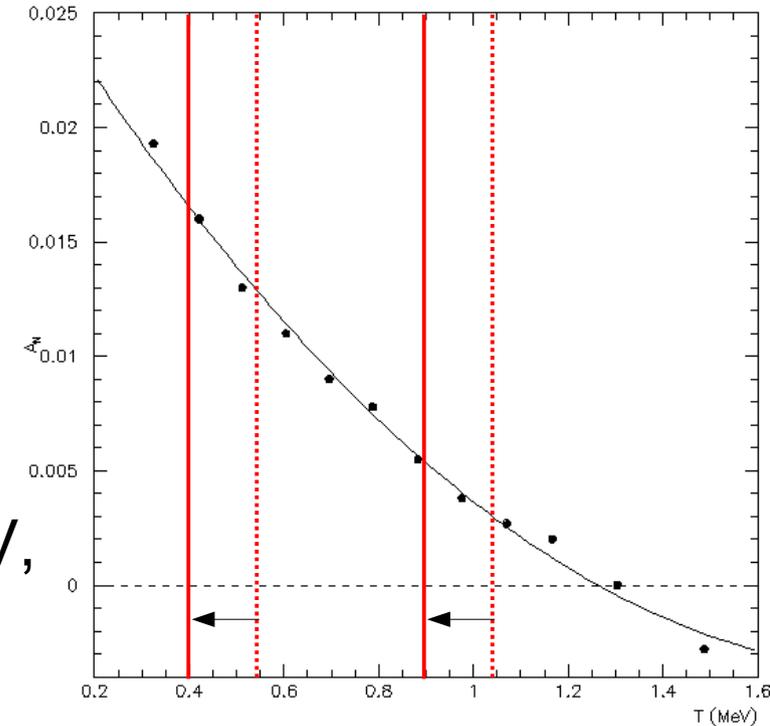
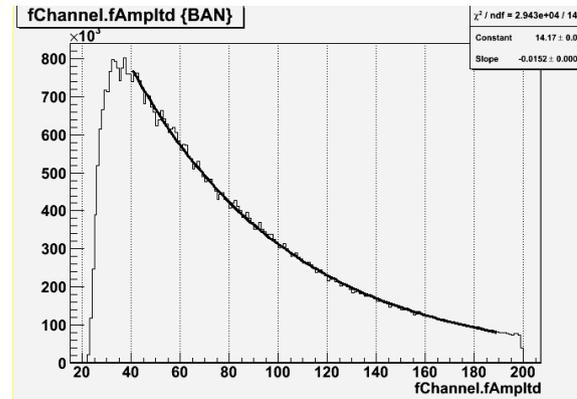
- A_N from pC/Hjet: target thickness dependence
- A_N corrected, Hjet normalization
- Up/Downstream pC comparison?

Final points & remarks

$dE/dx \rightarrow$ shifted effective A_N

- p↑-carbon scattering $A_N(T)$ (falling) function of kinetic energy T:

- $d\sigma/dT \propto \exp(-B \cdot T)$:



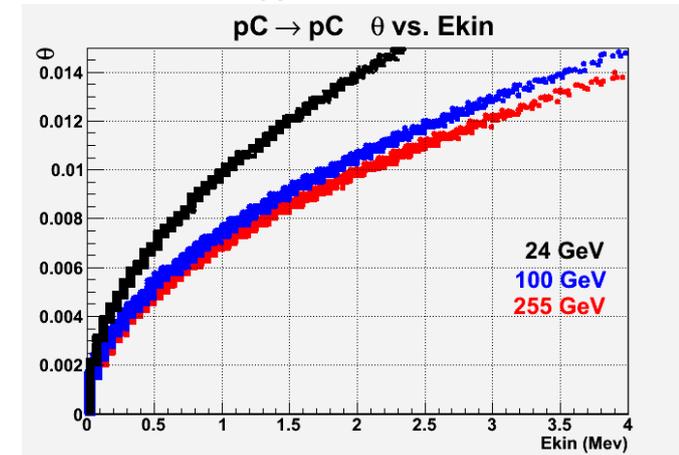
- Detectors measure in window $0.4 < T < 0.9$ MeV, (solid red lines) effective $A_N \propto d\sigma/dT \otimes A_N(T)$
- Finite target thickness: after p-C scattering, recoil C lose energy dE/dx
- Carbons scattered at higher T (dashed red lines) shift down into measured T window (solid red lines)
- These higher T carbons have smaller effective A_N

thicker targets \Rightarrow lower effective A_N

Multiple scattering

Scattered carbons:

- Carbon distribution ~uniform azimuthally: $dN/d\phi \propto 1 + PA_N \cos(\phi)$
- Polar scattering angles $\sim 90^\circ$:
for $0.4 < T < 0.9$ MeV, $\theta = 4\text{-}6$ mrad, narrow range
- Scattered carbons \sim disk around target \perp beam



Finite target thickness:

- Multiple Coulomb scattering in target smears θ :
 $RMS(\theta) = K \cdot \sqrt{L/T}$; L = target thickness, T = scattered C k.e.
 K = constant (PDG); **uncertain @ these low energies**
- Width of polar angle distributions \propto square root of target thickness

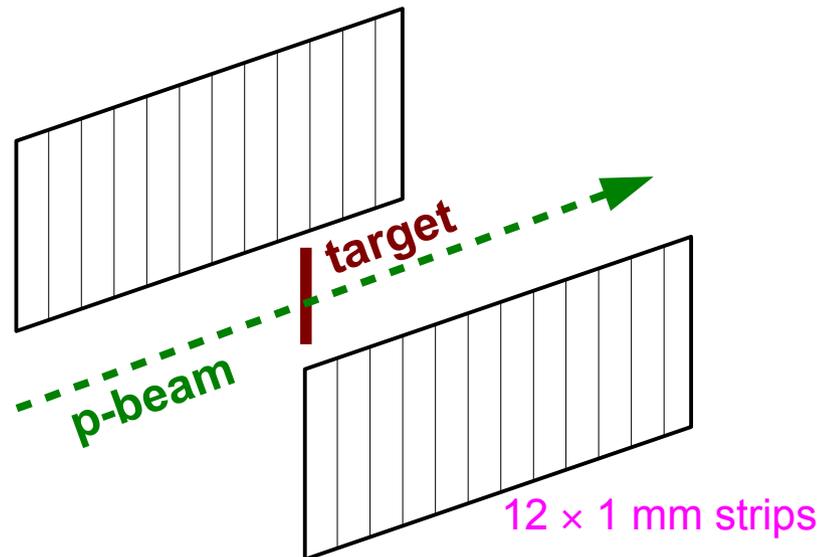
Program:

- Measure: polar angle distributions \Rightarrow target thickness
- Compare: effective $A_N \Leftrightarrow$ target thickness

Longitudinally segmented detectors

- Pair detectors segmented (1mm) along beam
- Strip polar angle $\Delta\theta \approx 5$ mrad

detectors 1&6
top 45°



#hits/channel distribution provides info:

- Centroid \Rightarrow longitudinal (Z) position of target
- Width \Rightarrow amount of multiple scattering through target

Toy Monte Carlo

- To extract info from distributions need model: simple Monte Carlo

- Model

- exponential in scattered carbon energy (on slide 2)
- $E \leftrightarrow \theta$ scattering angle dependence (kinematics)

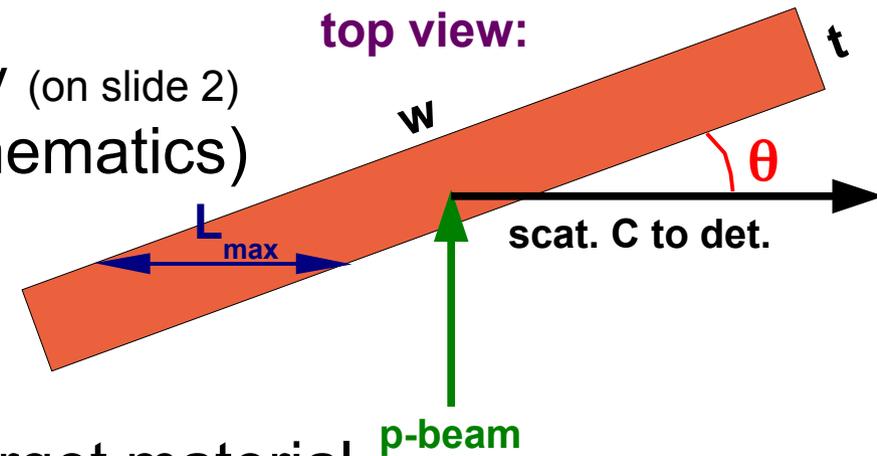
- passage of scattered carbon through *varying* target material $0 < L < L_{\max}$ with:

→ small angle multiple scattering in target material

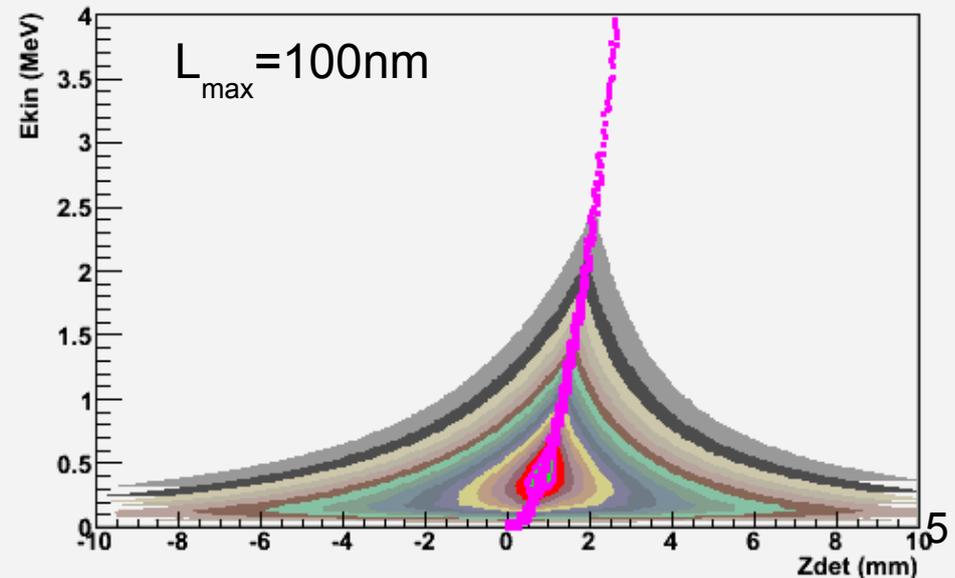
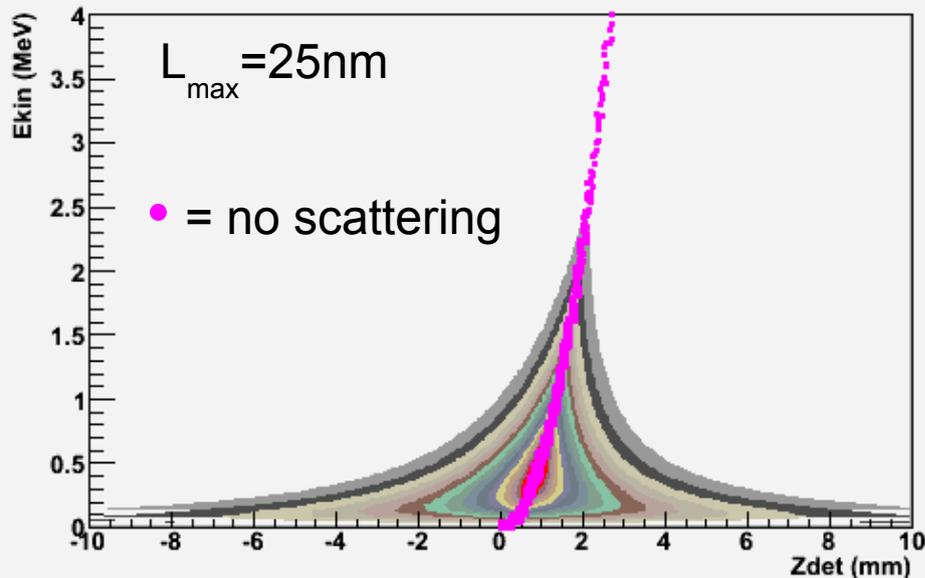
→ dE/dx carbon energy loss

- target → detector flight path 192 mm

- e.g. k.e. T vs. Z hit distributions; $L_{\max} = 0, 25, 100$ nm:



each E, L_{\max} superposition
gaussians $0 < \text{RMS} < L_{\max}$



Hit distribution fits

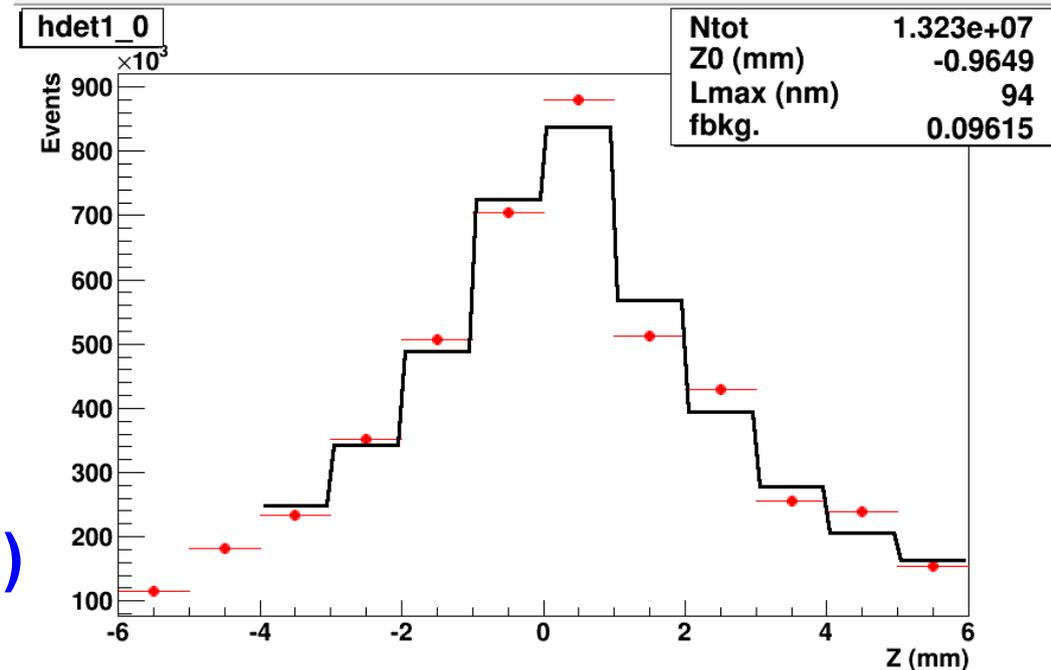
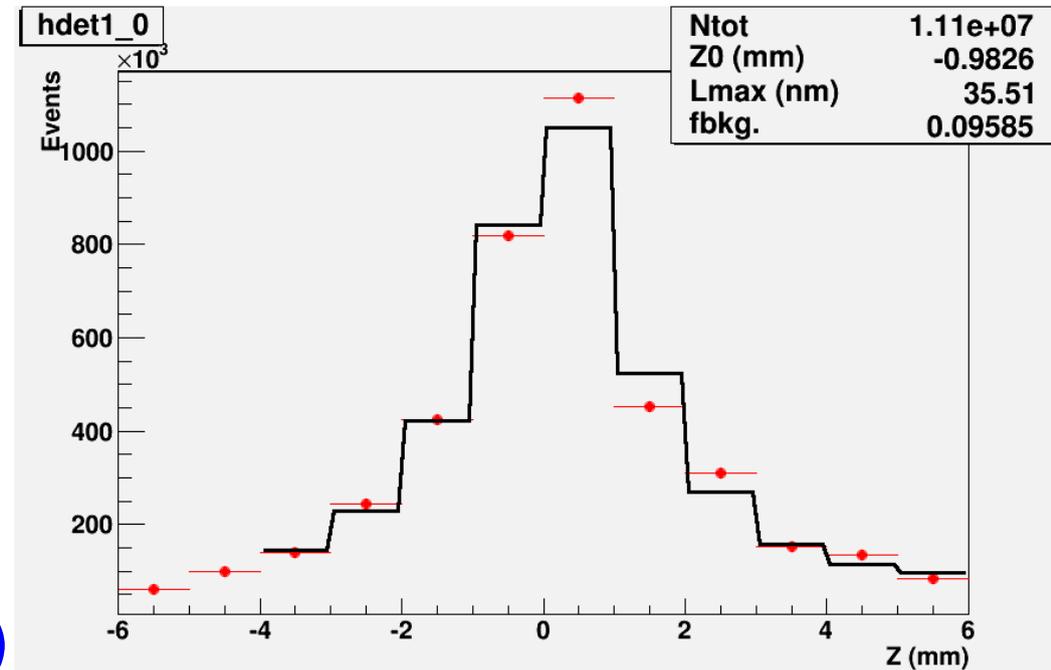
Fit parameters:

- Ntot: total # events (normalization)
- Z0: target longitudinal position
- **Lmax: target→detector thickness**
- fbkg.: flat background

narrower distribution
→ **thinner target (36 nm)**

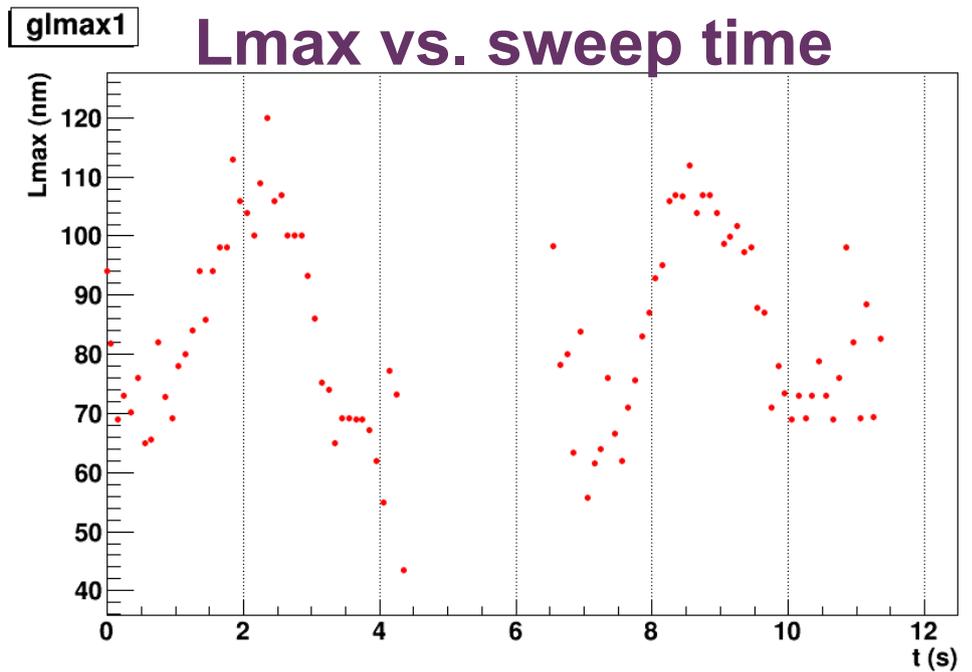
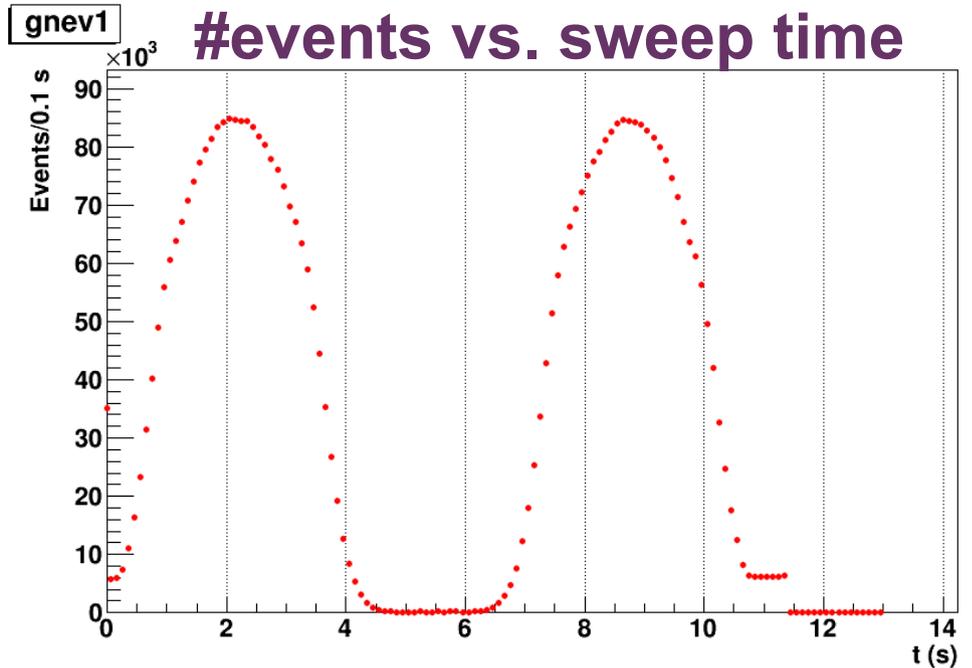
distribution width $\sim \sqrt{Lmax}$

wider distribution
→ **thicker target (94 nm)**



Mean Lmax in sweep

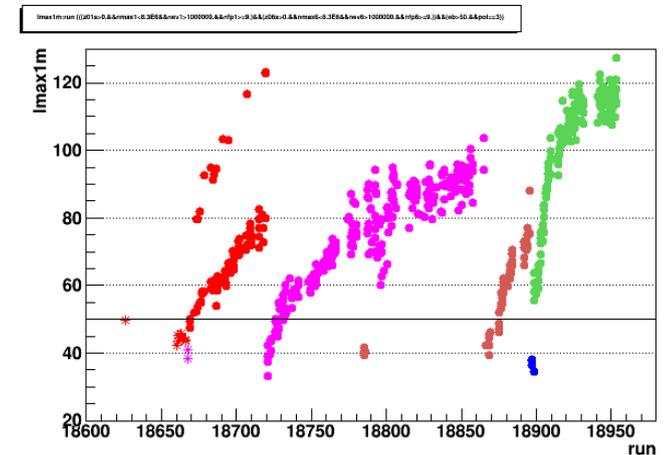
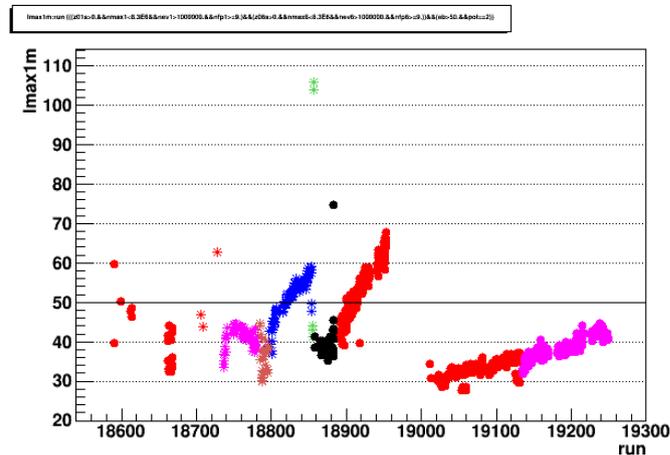
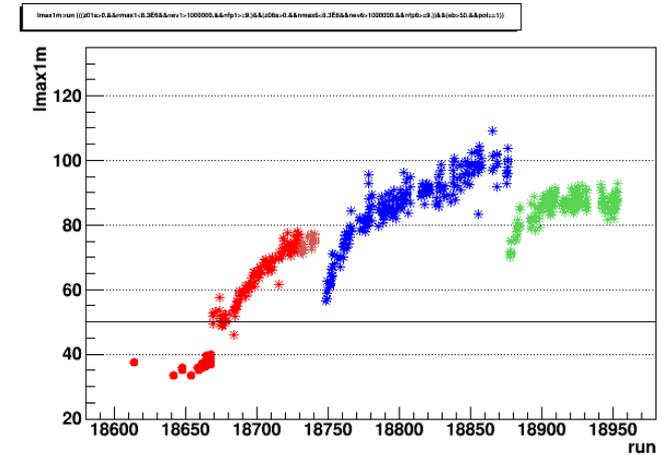
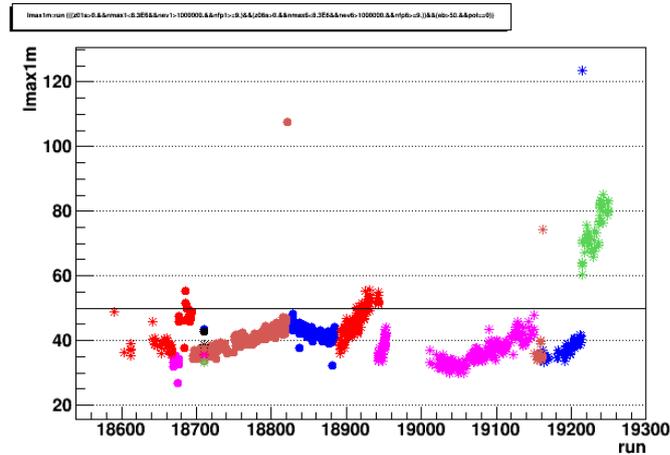
- Target is twisting, turning, ...
- Lmax varies as target sweeps across beam
- Take rate averaged Lmax:



Lmax history (Run15)

Run13
similar

- 4 polarimeters, different color each new target:



- Lmax definitely property of target: evolves slowly, jumps new target
- Lmax generally increases with target use; no explanation.
- BUT: - targets manufactured, measured 50 ± 4 nm thick
 - Lmax must be ≥ 50 nm
 - many values here < 50 nm, some < 30 nm

Fudge factor

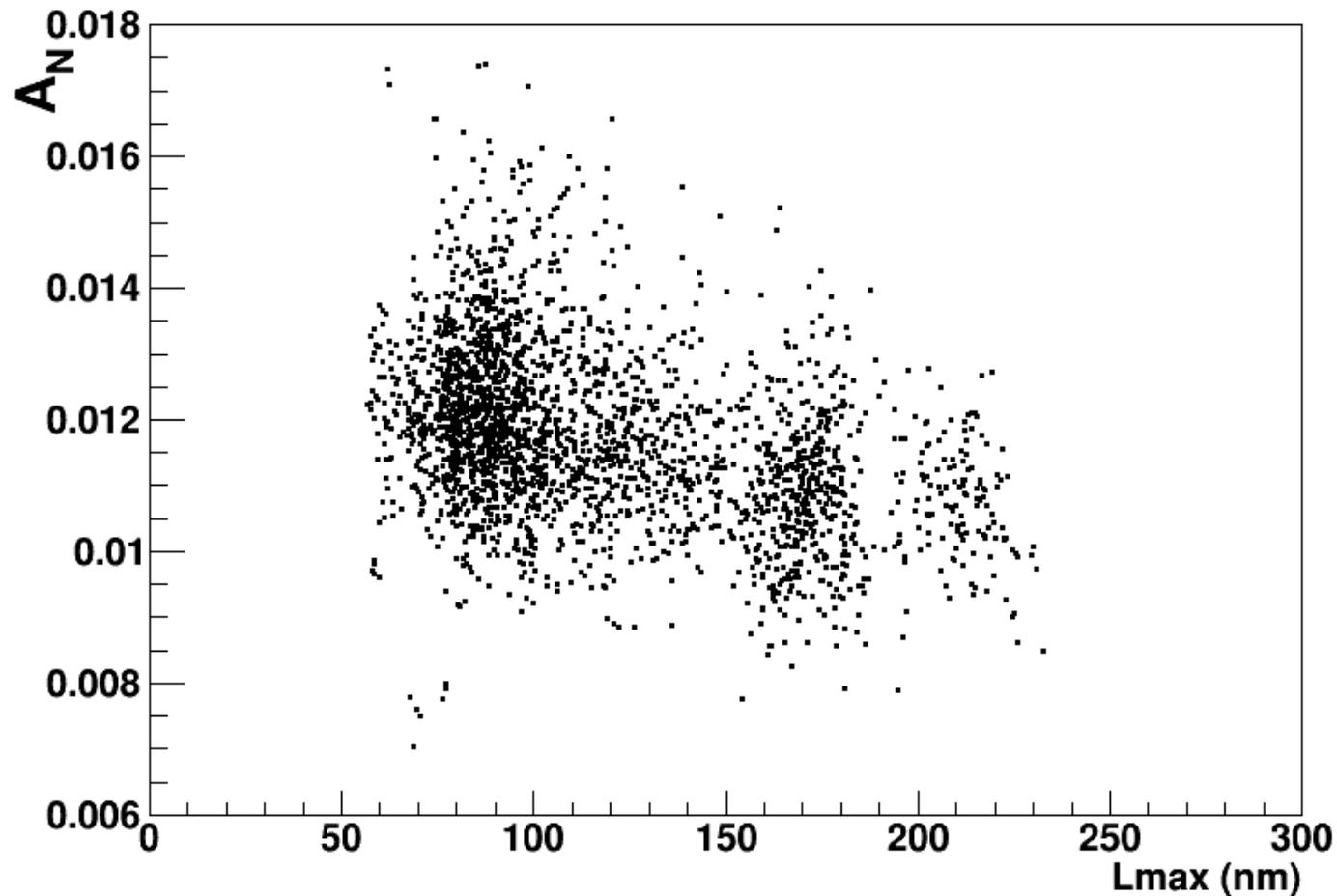
- Multiple scattering:
 $\text{RMS}(\theta) = K \cdot \sqrt{L/T}$; L = target thickness, T = scattered C k.e.
 K = constant (PDG)
- Relation said to be valid only down to energies much larger than our ~ 1 MeV
- Allow to fudge: $L_{\text{max}} \rightarrow 2 \times L_{\text{max}}$
- Now measured $L_{\text{max}} > 50$ nm, consistent with reality
- Corresponds to $K \rightarrow K/1.4$, 40% fudge

A_N from Hjet

- pC measures asymmetry $\epsilon = P A_N$
- Have absolute P from Hjet (per fill)
- Each pC measurement determine: $A_N = \epsilon / P_{\text{Hjet}}$
 - no correction of P_{Hjet} for dP/dt (yet)
 - large stat. uncert.: Hjet $\sim 7\%$, pC $\sim 4\%$
- Each pC measurement plot A_N vs. (fudged) Lmax...

A_N vs. L_{max}

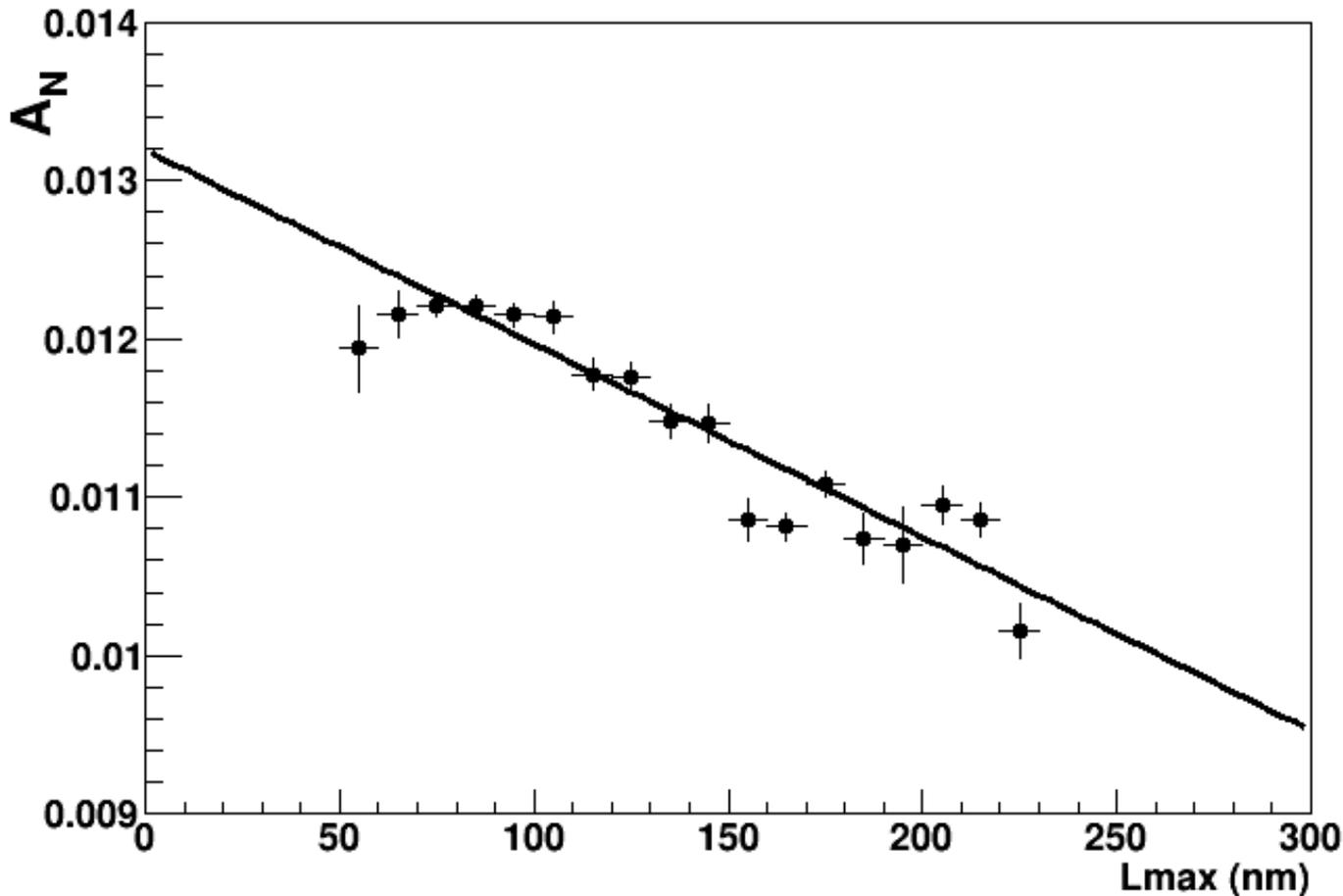
- Take L_{max} average from det. 1&6
- Scatter plot:



- A lot of stat. fluctuations, but downward trend apparent

A_N vs. L_{max}

- Take L_{max} average from det. 1&6
- Profile plot, all polarim., Run15:



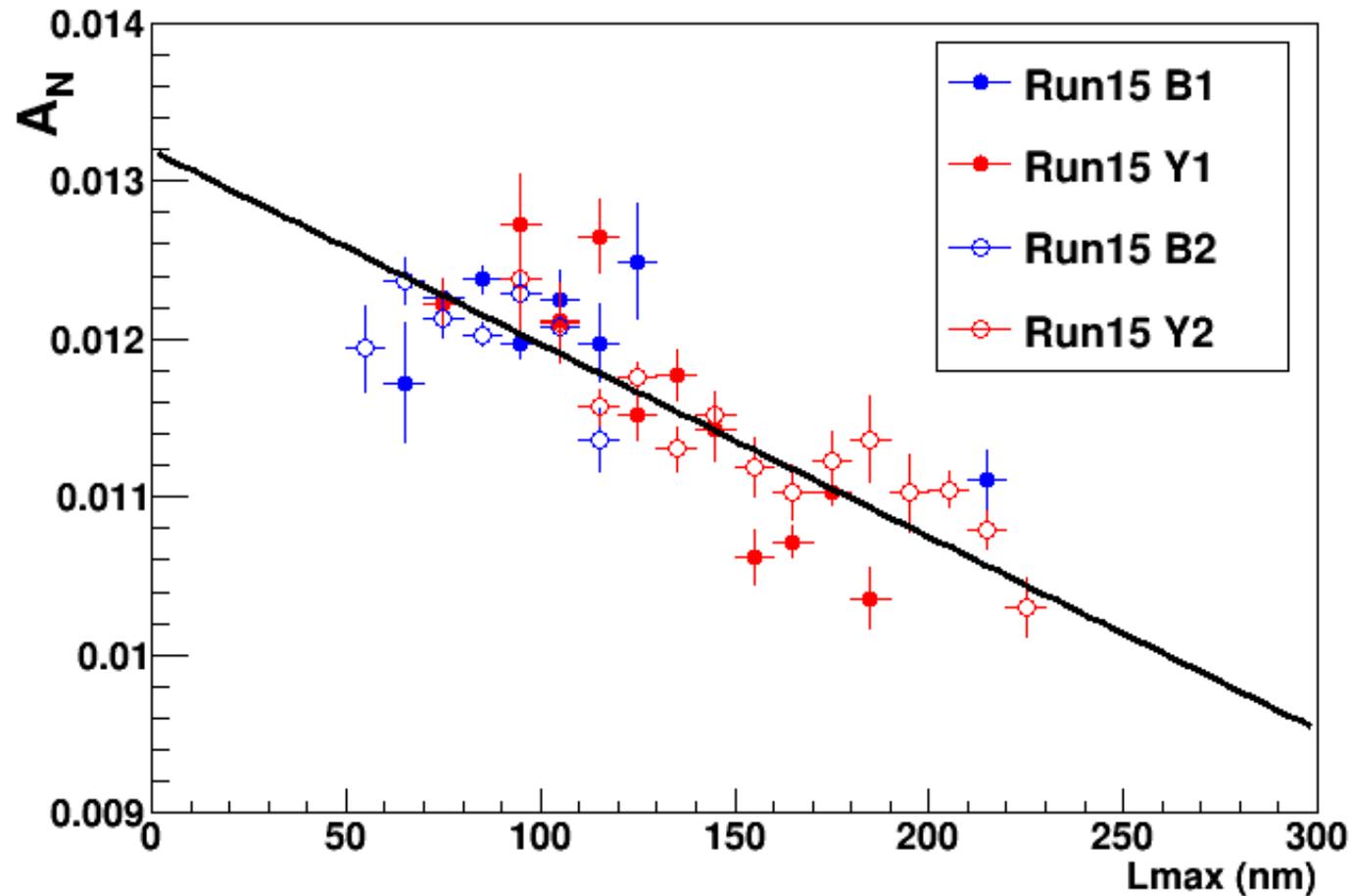
Fit: $A_N = A_{N0} (1 - \alpha \cdot L_{max})$

- $A_{N0} \approx 0.0132$
- $\alpha \approx 9 \times 10^{-4} \text{ nm}^{-1}$

- Downward trend statistically significant
- A_N changes $\sim 10\%$ across 100 nm

A_N vs. L_{\max}

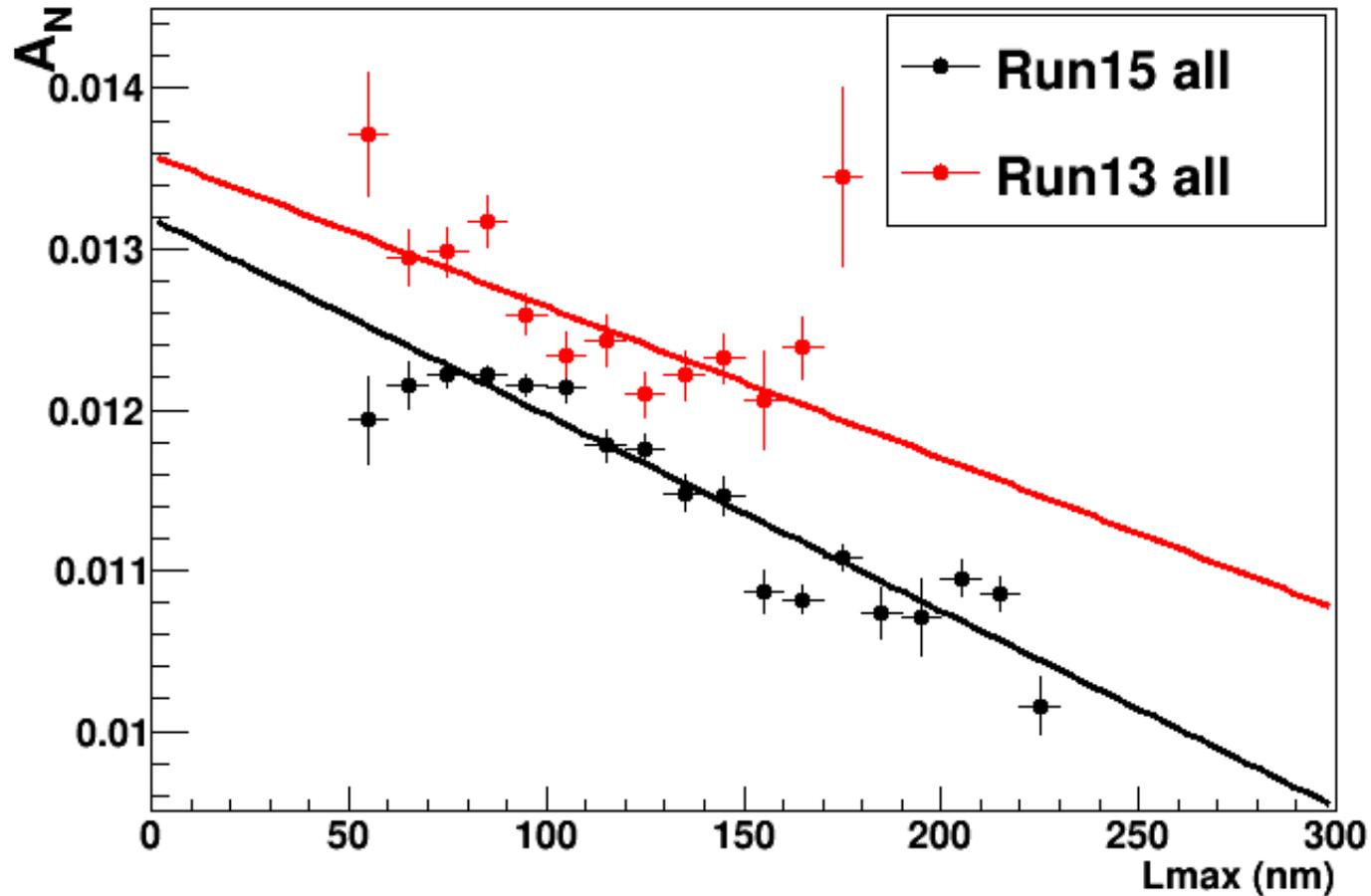
- Run15, each polarim. separately:



- Not all polarim. cover large L_{\max} range
- But all consistent, lie along fit to all polarim.

A_N vs. L_{max}

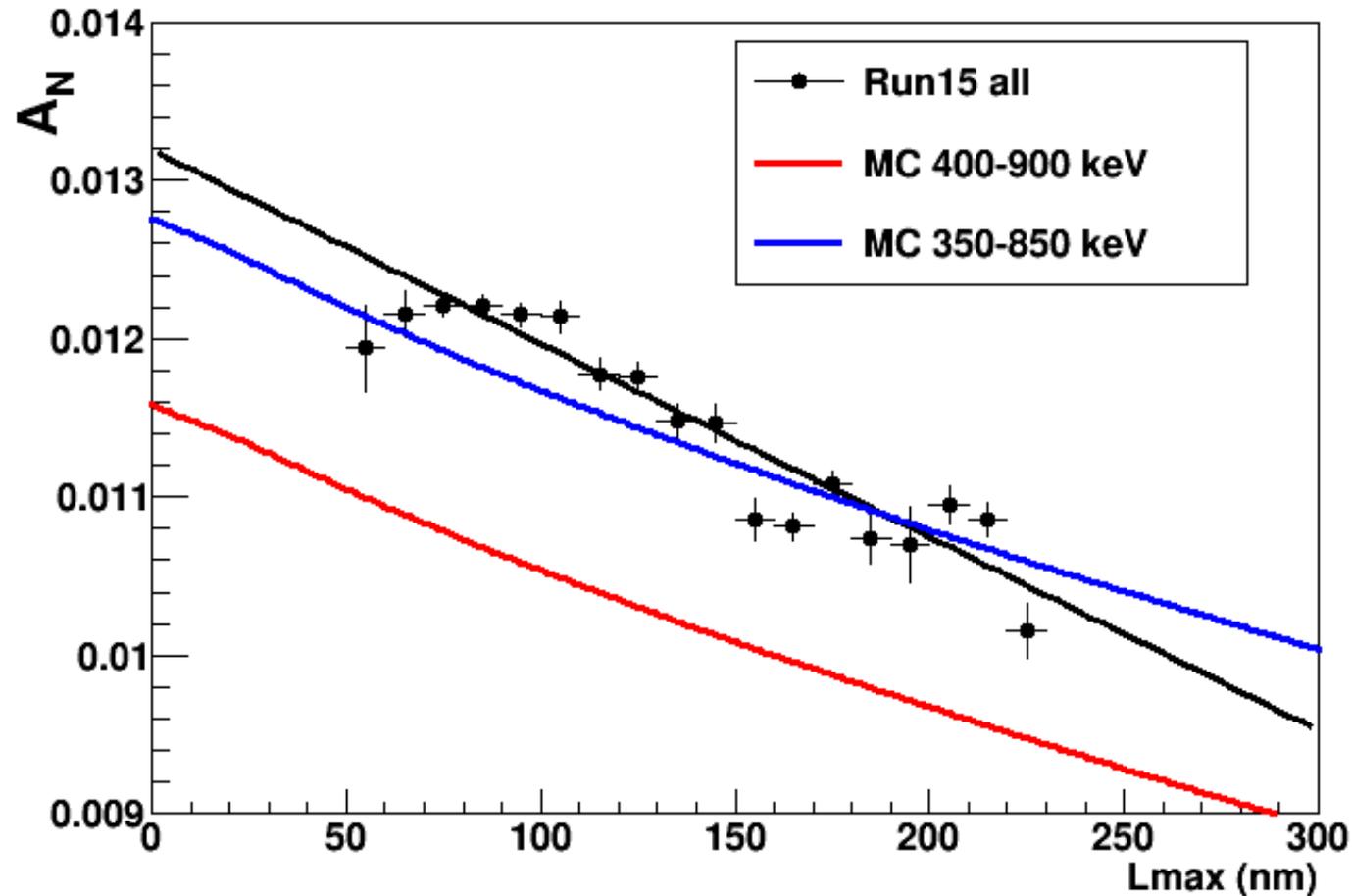
- Run13, Run15 comparison:



- Quite similar, but somewhat different slopes

A_N vs. L_{max}

- Get A_N vs. L_{max} from the toy MC:

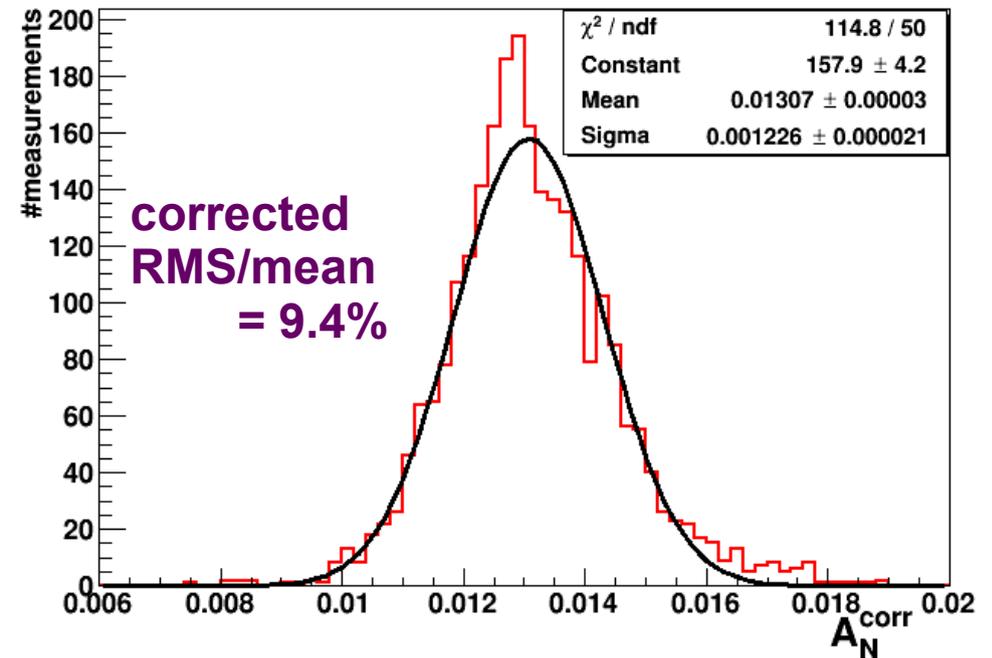
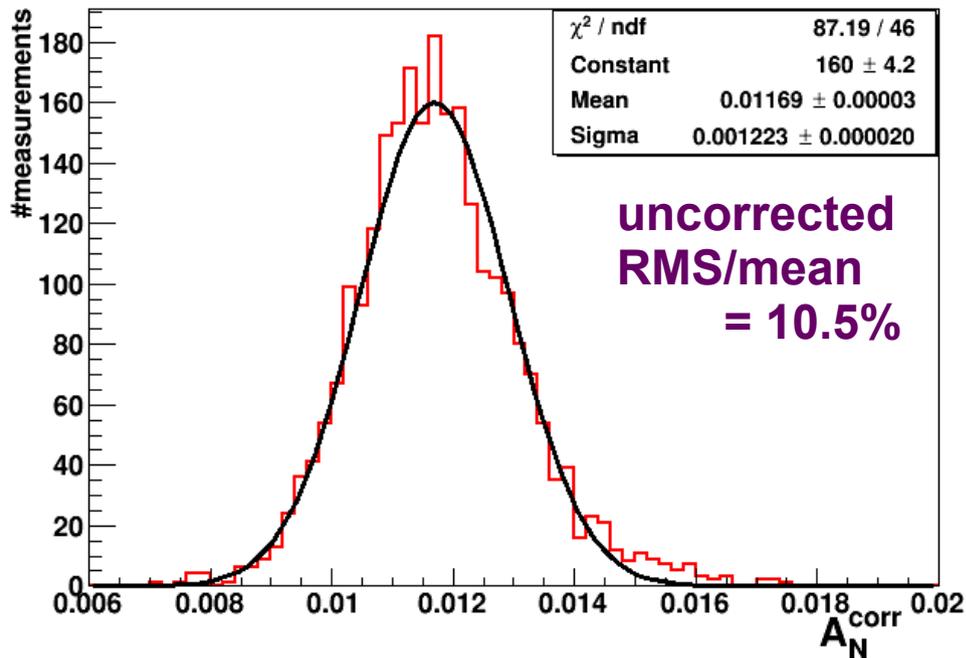


- Shifts in A_N scale, E-window can give good data description
- Overall pretty consistent with the picture

A_N corrected, Hjet normalization

- Correct each measurement for Lmax dependence in Hjet normalization:

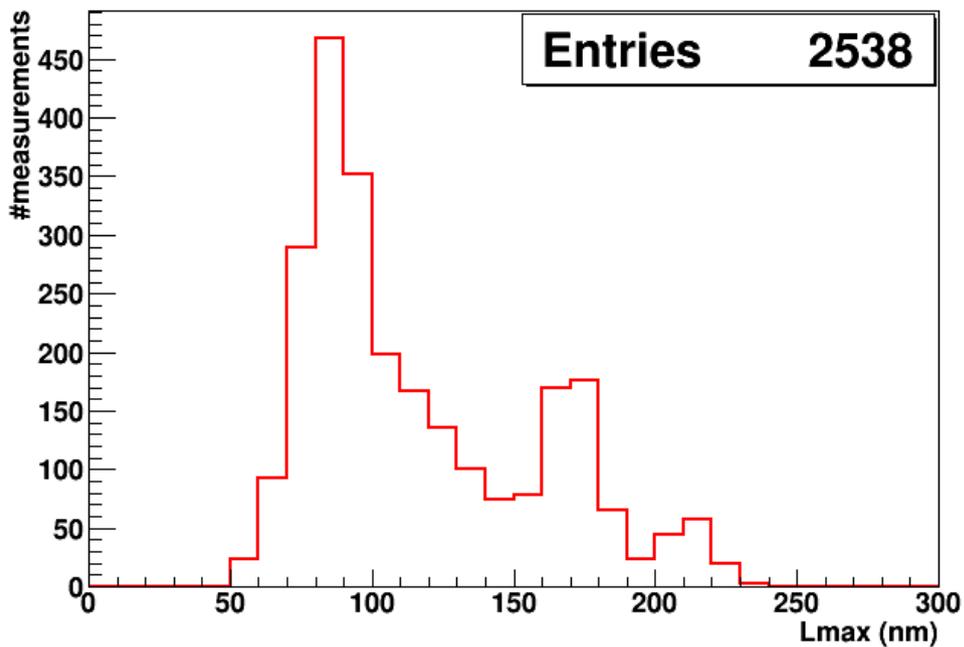
$$A_N^{\text{corr}} = (\epsilon / P_{\text{Hjet}}) / (1 - \alpha \cdot L_{\text{max}})$$



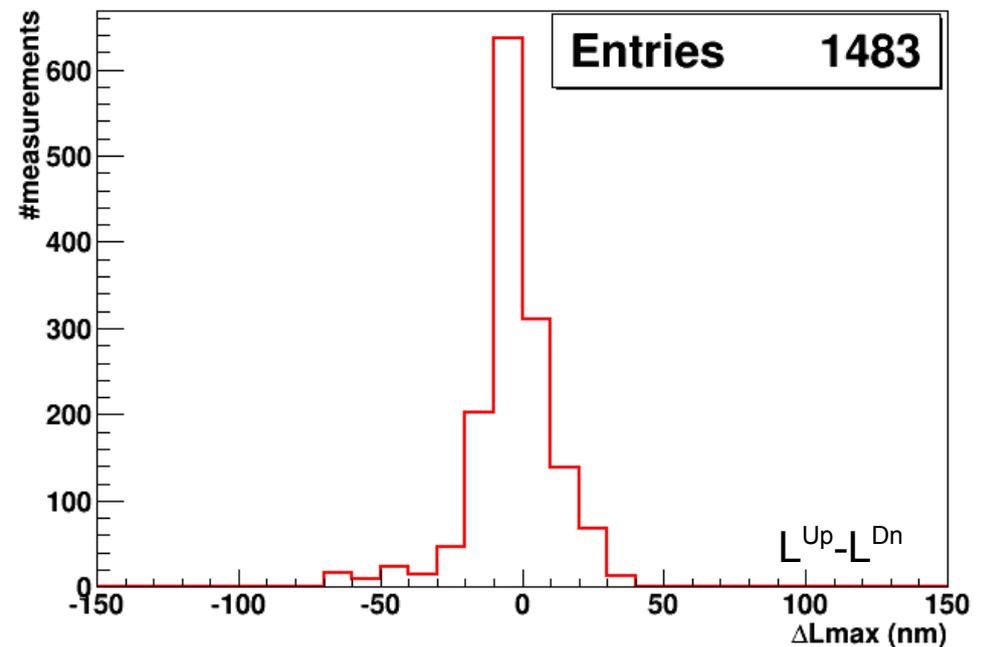
- Modest ~10% improvement in RMS/mean
- Handicapped by Hjet large stat. uncert.
- What about Up/Downstream pC comparison?

Up/Downstream compare?

- Lmax dependent A_N , pC asymmetry: $\epsilon = P \cdot A_{N0} (1 - \alpha \cdot L_{\max})$
- Take ~simultaneous Up/Dn measurements, $P \sim \text{constant}$
- Then: $\epsilon^{\text{Up}}/\epsilon^{\text{Dn}} = (1 - \alpha \cdot L^{\text{Up}})/(1 - \alpha \cdot \pi^{\infty K}) \approx 1 - \alpha \cdot (L^{\text{Up}} - L^{\text{Dn}}) = 1 - \alpha \cdot \Delta L_{\max} \in Y$
- Should be able to check with high stat. pC measurements, but:



- Lmax distribution for pC/Hjet vs. Lmax (slide 12)
- Lmax spans >150 nm



- ΔL_{\max} distribution for Up/Downstream comparison (U/D meas. within 10 min.)
- ΔL_{\max} spans <50 nm
- Too small lever arm...

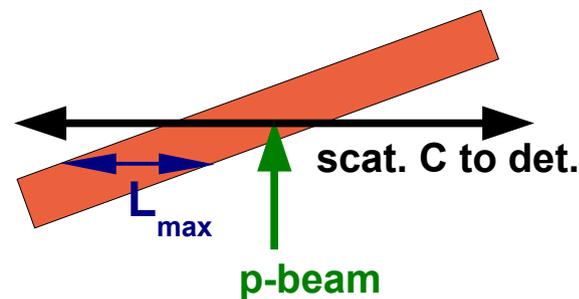
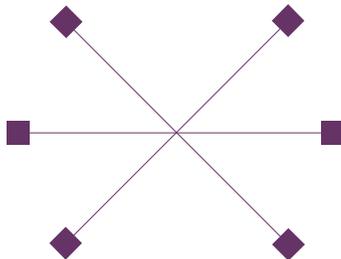
Final points

Use:

- Whatever theoretical details & parameters, see empirical relation
- Parameterize: $A_N = A_{N0} \cdot (1 + \alpha \cdot L_{\max})$
- Determine intercept A_{N0} , slope α from these pC/Hjet studies
→ this would replace pC/Hjet normalization, with 2 param. all 4 polar.
- Each pC measurement: $P = \epsilon / A_{N0} \cdot (1 + \alpha \cdot L_{\max})$

Further improvements:

- So far hit distributions full T range 0.4-0.9 MeV (histograms available)
 - do in more T bins
 - wider distributions @ lower T? Confirm mult. scat.
- If we had stable 1mm detectors:
 - each polarim. all 6 detectors 1mm longitudinally segmented
 - opposite detectors should have same L_{\max} ; confirm hypotheses



Last remark

- This correction takes account of expected target effects
 - If we also improved our questionable carbon energy energy calibration, absolute E-scale:
 - Determine A_{NO} , α for precise energy window(s) with pC/Hjet data
- ⇒ **Biggest steps to an *absolute* pC measurement, i.e. w/o Hjet**

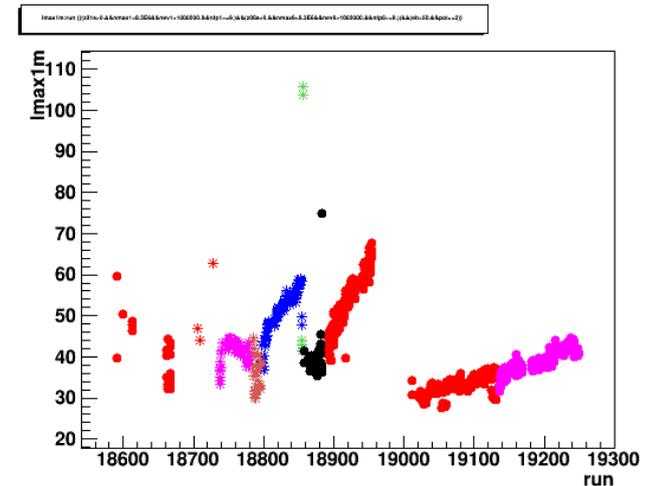
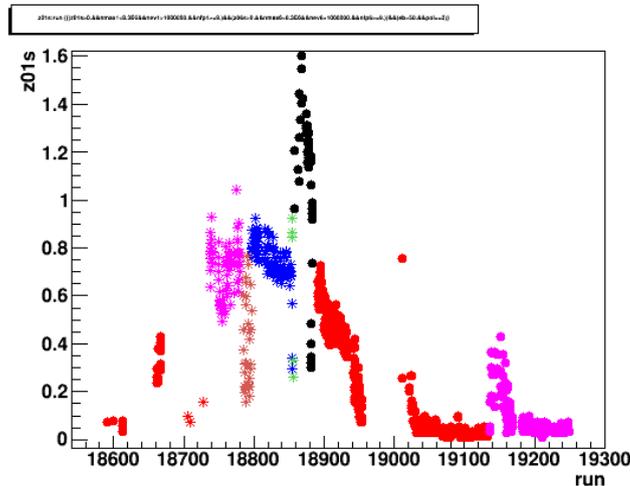
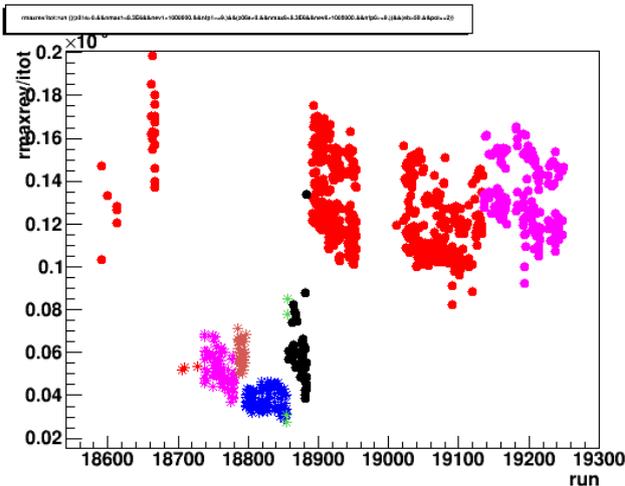
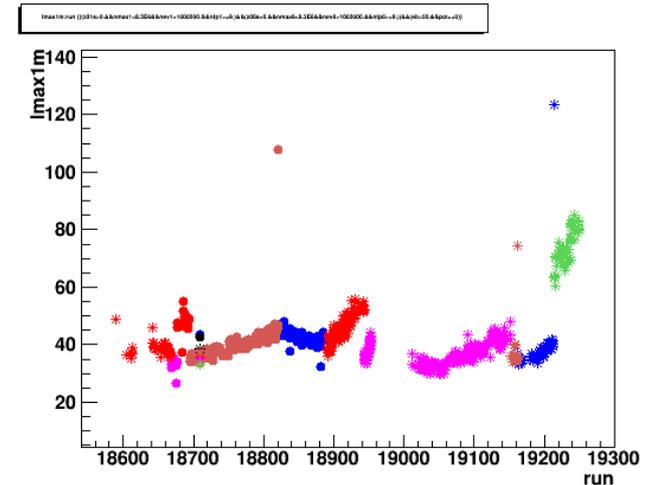
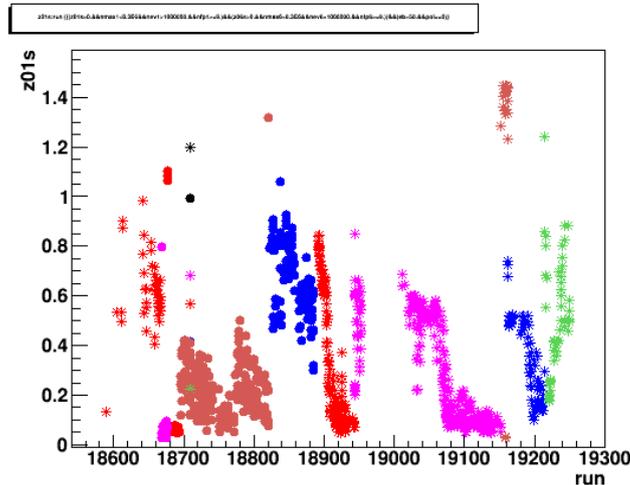
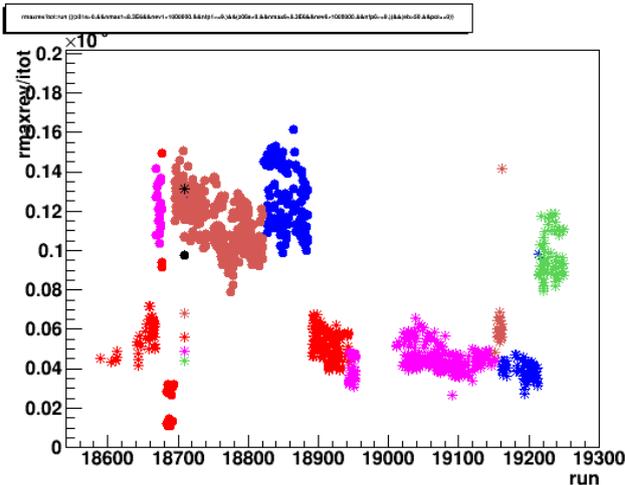
Extras

2015 Blue target properties

material in beam

longitudinal sway

Lmax



- Take max. rate in sweep
- rate \propto (material) \times $(I_p / \sigma_{\text{beam}})$

- Variation of Z0 across sweep

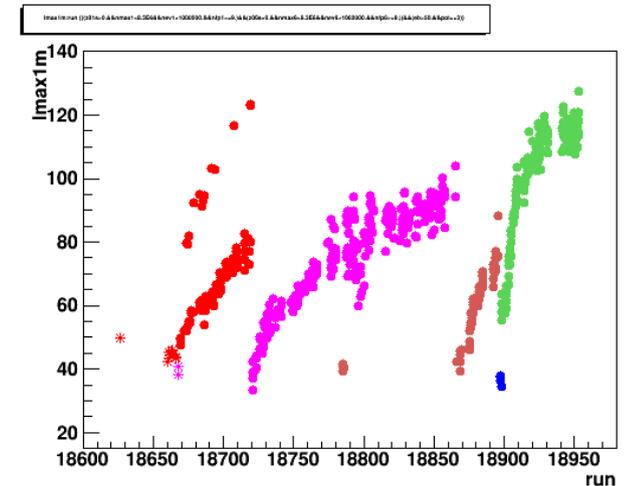
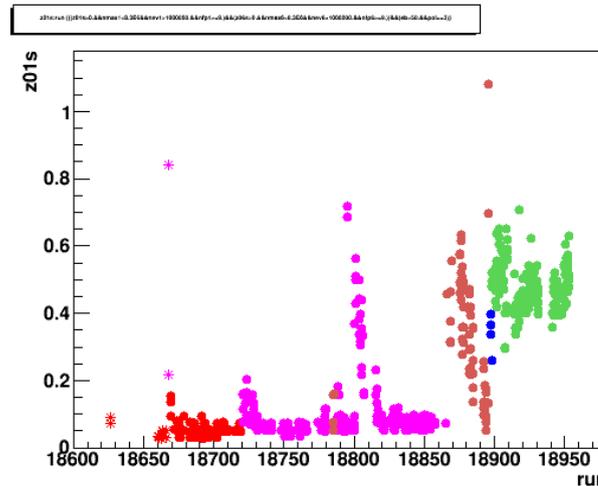
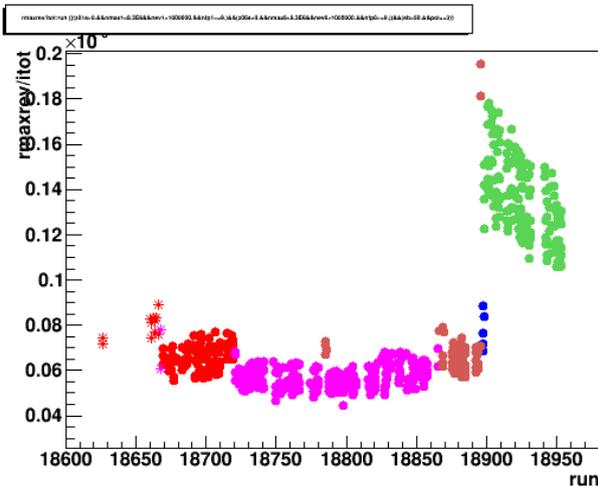
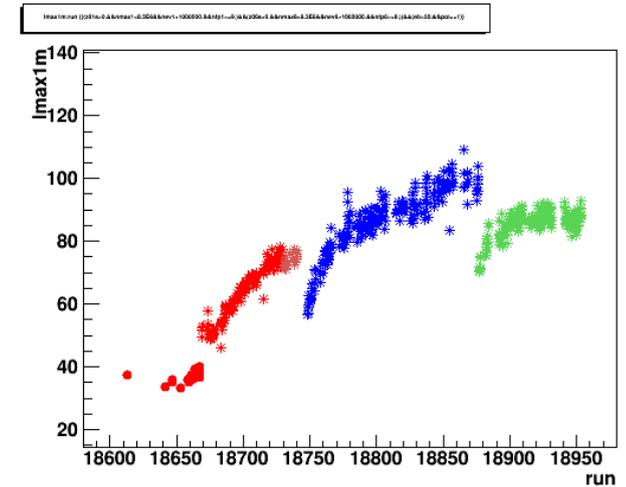
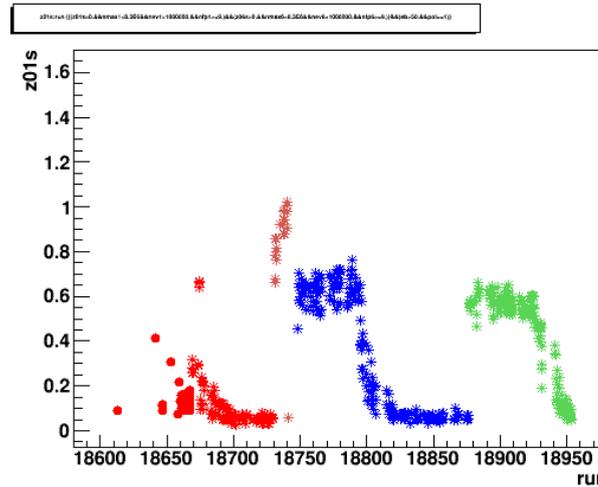
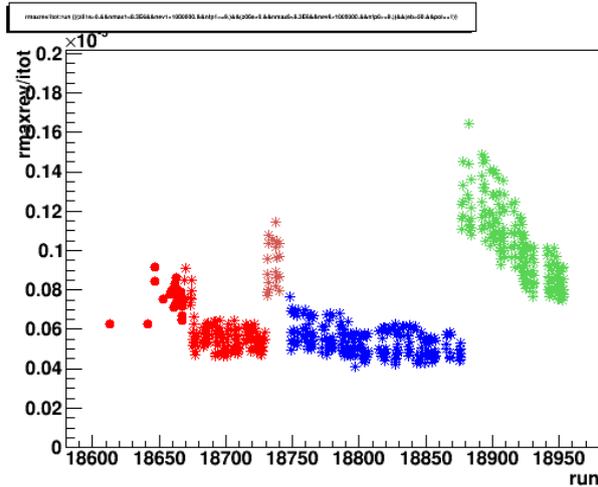
- slides 6,7

2015 Yellow target properties

material in beam

longitudinal sway

Lmax



- Take max. rate in sweep
- rate \propto (material) \times $(I_p / \sigma_{\text{beam}})$

- Variation of Z0 across sweep

- slides 6,7